Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/046,880	BYSTRYN, JEAN-CLAUDE	
Examiner	Art Unit	
Christopher H. Yaen	1643	

SEARCHED				
Class	Subclass	Date	Examiner	
		:		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
424	277.1	5/28/2007	СНҮ	
	J			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE		EXMR	
updated searches	5/28	/2007	СНҮ	
palm database search	5/28	/2007	СНҮ	